

<b>Notice of References Cited</b>	Application/Control No. 10/717,154	Applicant(s)/Patent Under Reexamination XIAO ET AL.	
	Examiner Gail Verbitsky	Art Unit 2859	Page 2 of 2

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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